

**Notice of References Cited**

Application/Control No.

10/636,035

Applicant(s)/Patent Under

Reexamination

BHAT ET AL.

Examiner

Jennifer M. Kennedy

Art Unit

2812

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,743,475 B2	06-2004	Skarp et al.	427/255.31
	B	US-2002/0135048 A1	09-2002	Ahn et al.	257/632
	C	US-6,469,333 B1	10-2002	Takai et al.	257/295
	D	US-6,358,789 B2	03-2002	Lee, Sang-Hyeob	438/239
	E	US-6,777,776 B2	08-2004	Hieda, Katsuhiko	257/532
	F	US-2002/0086556 A1	07-2002	Ahn et al.	438/785
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.